# Perpendicular susceptibility of completely shielded elliptical and rectangular superconducting films 

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#### Abstract

The perpendicular susceptibility $-\chi_{0}$ of completely shielded elliptical and rectangular superconducting films with different aspect ratios has been calculated accurately. The obtained $\chi_{0}$ may be compared with the measured low-field limit of ac susceptibility to check the quality of superconducting films, and used as a scaling parameter to obtain field amplitude dependent complex critical-state ac susceptibility.


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## 1. Introduction

Perfect diamagnetism is a fundamental property of any superconductor of large dimensions compared with the London penetration depth. This means that when an enough small field $H_{a}$ is applied to the superconductor, its internal flux density $B=0$ or equivalently, the material susceptibility $\chi=-1$ [1]. The field may be applied at a high temperature and then the sample is cooled to the superconducting state (the Meissner effect) or applied after the sample is zero-field cooled to the superconducting state (the shielding effect). The same susceptibility occurs for both cases at the same temperature, so that such a diamagnetism may be studied quantitatively by low-frequency ac susceptibility measurements if the susceptibility of a completely shielded body, $-\chi_{0}$, with the same shape and dimensions as those of the measured sample is accurately calculated. The present work is devoted to such calculations for thin films when $H_{a}$ is applied perpendicular to the film surface.

Exact $\chi_{0}$ has been calculated analytically for a thin disk of radius $b$ and thickness $t$ and an infinitely long thin strip of width $2 b$ and thickness $t[2-4]$; the results are

[^0]$\chi_{0}=\frac{8 b}{3 \pi t}($ disk $)$,
$\chi_{0}=\frac{\pi b}{2 t}$ (strip).
We will show that both results may be derived from the known demagnetizing factor of relevant ellipsoids, as already been described in [5]. Using this technique, $\chi_{0}$ of elliptical films of different values of semiaxes $a$ and $b$ and thickness $t$ will be calculated exactly in Section 2.

Less accurate values (with errors on the order of $1 \%$ ) of numerically calculated $\chi_{0}$ for rectangular films were given in [6]. Recently, a new procedure has been proposed, with which $\chi_{0}$ of a square film is calculated to a precision of $0.1 \%$ [7]. Extending the work in [7], we will calculate $\chi_{0}$ up to a similar precision for rectangular films of dimensions of $2 a \times 2 b \times t$ in Section 3 .

Although elliptical films of $a \neq b$ may not be of practical importance, their results can be compared with those of rectangular films, and, as described below, treating the problem of elliptical films is a good preparation to optimize the calculation conditions of the numerical calculations for rectangular films.

It has to be commented that owing to strong demagnetizing effects, type-I or type-II superconducting films will present an intermediate or vortex state, respectively, but not a Meissner state in a
perpendicular $H_{a}$ even if $H_{a}$ is very low [1]. Thus, the calculated $-\chi_{0}$ for the completely shielded state should be compared with the measured low-frequency ac susceptibility after extrapolation to $H_{a}=0$. Moreover, the effect of the two-dimensional screening length has to be taken into account in such a comparison [3,4,8]. If the film is a hard type-II superconductor, an accurate $\chi_{0}$ may not only be used as a standard for quality check of the film, it may also be used to check the validity of a scaling law proposed by Gilchrist [9], by which the field dependent critical-state ac susceptibility of films of different shape may be obtained from the analytical results of thin disk or strip, as described in [7].

## 2. Susceptibility of elliptical films

There is a relation between $\chi_{0}$ and the demagnetizing factor $N$ of a completely shielded ellipsoid when $H_{a}$ is applied along a principal axis [10]:
$\chi_{0}=\frac{1}{1-N}$.
This equation may be used for obtaining the perpendicular $\chi_{0}$ of an elliptical film of semiaxes $a$ and $b$ and thickness $t$ from the known $N$ value of an ellipsoid of semiaxes $a, b$, and $c$, with
$c=3 t / 4$,
so that its volume is the same as that of the film. If $a \geqslant b \geqslant c$, the exact formula for $N$ of this ellipsoid is [11,12]
$N=\frac{\cos \phi \cos \theta}{\sin ^{3} \theta\left(1-k^{2}\right)}\left[\frac{\sin \theta \cos \phi}{\cos \theta}-E(k, \theta)\right]$,
where $E(k, \theta)$ is the second kind elliptical integral and
$\cos \theta=\frac{c}{a}, \quad \cos \phi=\frac{b}{a}, \quad k=\frac{\sin \phi}{\sin \theta}$.
Substituting $N$ in Eq. (3) by Eq. (5), where $c$ is replaced by Eq. (4), and considering $c / a \rightarrow 0$, one obtains for the film that
$\chi_{0}=\frac{4 b}{3 t E(k)}$,
where $E(k)$ is the second kind complete elliptical integral.
The above derivation may be explained as follows. Assume that the ellipsoid is centered at the origin with its semiaxes $a, b$, and $c$ lying along the $x, y$, and $z$ axes, respectively. When $H_{a}$ is applied in the positive $z$ direction, magnetization $M$ and field $H$ are directed to the negative and positive $z$ direction, respectively, and both are uniform inside the body. The condition of complete shielding $B_{z}=\mu_{0}(M+H)=0$ is realized by a certain distribution of magnetic moment density $g(x, y)=\operatorname{Mt}(x, y)$, where $t(x, y)$ is the local thickness of the ellipsoid along the $z$ axis. When $c / a \rightarrow 0$, the same internal $B_{z}=0$ may be realized for the thin film at the same $H_{a}$

Table 1
Perpendicular $\chi_{0} t /(2 b)$ of elliptical films of semiaxes $a$ and $b$ and thickness $t$ and rectangular films of dimensions $2 a \times 2 b \times t$.

| $a / b$ | $\chi_{0} t /(2 b)$ (ell.) | $\chi_{0} t /(2 b)$ (rec.) |
| :--- | :--- | :--- |
| 0.7143 | 0.3512 | 0.3771 |
| 1 | 0.4244 | 0.4547 |
| 1.4 | 0.4917 | 0.5279 |
| 2 | 0.5505 | 0.5940 |
| 3 | 0.5986 | 0.6533 |
| 5 | 0.6346 | 0.7042 |
| 7 | 0.6478 | 0.7271 |
| 10 | 0.6562 | 0.7442 |
| 20 | 0.6634 | 0.7643 |
| $\infty$ | 0.6667 | 0.7854 |

with the same moment density $g(x, y)$. Thus, the same total moment $m$ occurs for both cases, and $\chi_{0}$ defined by
$\chi_{0} \equiv \frac{-m}{H_{a} V}$,
where $V$ is the volume of the body, is also the same if both bodies have the same $V$, so that Eq. (4) holds and Eq. (7) is obtained for the film.

Eq. (1) for a circular disk may be derived from Eq. (7) when $a / b=1$. It is also derived from Eq. (7) for an infinitely long elliptical film that
$\chi_{0}=\frac{4 b}{3 t} \quad(a / b \rightarrow \infty)$.
Numerical results of $\chi_{0} t /(2 b)$ of elliptical films for several values of $a / b$ are listed in Table 1 and plotted in Fig. 1.

## 3. Susceptibility of rectangular films

Unlike the case of elliptical films whose exact $\chi_{0}$ may be calculated analytically, the $\chi_{0}$ for rectangular films has to be calculated numerically, except when $a / b \rightarrow \infty$, for which the exact Eq. (2) has been derived. In the present work, the film is divided into equal rectangular elements and a magnetic energy minimization procedure is used for numerical computations [13,14,7].

It may be realized from the above approach for calculating $\chi_{0}$ of elliptical films that the correct $g(x, y)$ for the completely shielded elliptical film is proportional to the local thickness $t(x, y)$ of its equivalent ellipsoid; $g(x, y)$ has negative values and presents a broad minimum in the central region and $g(x, y)=0$ occurs at the edge with an infinite gradient, which corresponds to an infinite screening current density $J$. The numerical calculations for rectangular films may be optimized based on these observations.

In general, the rectangular film of sides $2 a$ and $2 b$ may be divided into $n_{a} \times n_{b}$ rectangular cells, each having an area of $A_{c}=4 a b /\left(n_{a} n_{b}\right)$. Knowing that $g(x, y)$ for the elliptical case is proportional to $t(x, y)$, which has elliptical isometric loops of aspect ratio of $a / b$, an optimum condition of $n_{a}=n_{b}$ with $A_{c}=4 a b / n_{a}^{2}$ should be applied for the numerical calculations. Under this condition, the correct $g(x, y)$ function for the film is approximated by an $\left(n_{a}+1\right) \times\left(n_{a}+1\right)$ array of $g(i, j)$, where indices $i, j=0,1,2, \ldots, n_{a}$ correspond to the node positions and $g(i, j)=0$ holds if $i, j=0$ or $n_{a}$. Applying a field $H_{a}$ in the positive $z$ direction, the moment $g(i, j) A_{c}$ is always negative to ensure internal $B_{z}(i, j)=0$ everywhere. This condition is approximately satisfied by executing the magnetic energy minimization procedure mentioned above. Starting with $g(i, j) A_{c}=0$, a positive value of $H_{a}$ is applied and a position $(i, j)$, at which decreasing $g(i, j) A_{c}$ by a given negative moment increment $\Delta m \equiv \Delta g A_{c}$ would yield the maximum decrease in the magnetic energy, is looked for. When this place is found the $g(i, j) A_{c}$ is changed by adding $\Delta m$. This process is repeated until the energy cannot be further minimized, so that a set of $g(i, j) A_{c}$ is found for this value of $H_{a}$, from which $\chi_{0}$ is calculated by
$\chi_{0}=\frac{-A_{c}}{H_{a} 4 a b t} \sum_{i, j=0}^{n_{a}} g(i, j)=\frac{-1}{H_{a} n_{a}^{2} t} \sum_{i, j=0}^{n_{a}} g(i, j)$.
In the program four $\Delta m$ 's were added to four symmetric nodes each time. Detailed computations are explained elsewhere [15]. It has been found that the calculated $\chi_{0} t /(2 b)$ decreases with increasing $H_{a}$ and decreasing $n_{a}$. For a fixed $n_{a}$, it has a linear relation with $1 / H_{a}$ when $H_{a}$ is high enough, as shown for $a / b=1$ in [7]. Another example is given in Fig. 2a for the case of $a / b=5$. Linearly extrapolating to $1 / H_{a}=0$ to reduce the discretization error owing to finite $\Delta m$, one gets a $\chi_{0} t /(2 b)$ for each value of $n_{a}$. Drawing the extrapolated $\chi_{0} t /(2 b)$ against $1 / n_{a}$, another linear relation is found, as

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